Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/767,039	FURUKAWA ET AL.
Examiner	Art Unit
Phat X. Cao	2814

	SEARCHED				
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Class	Subclass	Date	Examiner		
257	213	8/10/2005	PC		
257	220	8/10/2005	PC		
257	.263	8/10/2005	PC		
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
	1	<u>.</u>		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST: IS&R and BRS	8/10/2005	PC		